



US006455849B1

(12) **United States Patent**
Hilton et al.

(10) **Patent No.:** **US 6,455,849 B1**
(45) **Date of Patent:** **Sep. 24, 2002**

(54) **NORMAL METAL BOUNDARY CONDITIONS
FOR MULTI-LAYER TES DETECTORS**

(75) Inventors: **Gene C. Hilton; John M. Martinis,**
both of Boulder; **Kent D. Irwin,** Lyons;
David A. Wollman, Louisville, all of
CO (US)

(73) Assignee: **The United States of America as
represented by the Secretary of
Commerce,** Washington, DC (US)

(*) Notice: Subject to any disclaimer, the term of this
patent is extended or adjusted under 35
U.S.C. 154(b) by 14 days.

(21) Appl. No.: **09/671,620**

(22) Filed: **Sep. 28, 2000**

Related U.S. Application Data

(60) Provisional application No. 60/157,741, filed on Oct. 5,
1999.

(51) Int. Cl.⁷ **H01L 39/00**

(52) U.S. Cl. **250/336.2**

(58) Field of Search 250/336.2; 374/183,
374/185; 338/18, 25; 505/847, 848, 849

(56) **References Cited**

U.S. PATENT DOCUMENTS

3,506,913 A	4/1970	Lambe et al.	324/248
4,403,189 A	9/1983	Simmonds	324/248
4,491,795 A	1/1985	Gelinas	324/248
5,053,706 A	10/1991	Ohkawa	324/248
5,162,731 A	11/1992	Fujimaki	324/248
5,185,527 A	2/1993	Bluzer	250/336.2
5,302,580 A	4/1994	Shimizu et al.	505/233
5,306,521 A	4/1994	Shimizu et al.	427/62
5,309,095 A	5/1994	Ahonen et al.	324/248
5,480,861 A	1/1996	Tanaka et al.	505/236
5,532,485 A	7/1996	Bluzer et al.	250/336.2

5,596,206 A	1/1997	Yamazaki	257/30
5,634,718 A	6/1997	Martinis et al.	374/32
5,641,961 A	6/1997	Irwin et al.	250/336.2
5,710,437 A	1/1998	Kurakado et al.	257/32
5,753,935 A	5/1998	Kurakado et al.	257/31
5,760,463 A	6/1998	Hato	257/662
5,866,252 A	2/1999	de Rochemont et al. ...	428/373
5,880,467 A	3/1999	Martinis et al.	250/310
5,880,468 A	3/1999	Irwin et al.	250/336.2
6,239,431 B1 *	5/2001	Hilton et al.	250/336.2

OTHER PUBLICATIONS

D.A. Wollman et al., "High-Resolution, Energy-Dispersive microcalorimeters spectrometer For X-ray microanalysis", *National Institute of Standards & Technology*, pp. 1-25.

G.C. Hilton et al., "Superconducting Transition-Edge Microcalorimeters For X-ray Microanalysis", *National Institute of Standards & Technology*, Sep. 15, 1998, pp. 1-5.

* cited by examiner

Primary Examiner—Constantine Hannaher

Assistant Examiner—Shun Lee

(74) *Attorney, Agent, or Firm*—Millen, White, Zelanoo & Branigan, P.C.

(57) **ABSTRACT**

Multi-layer transition-edge sensors (TES) having improved performance, a method for preparing them and methods of using them. Specifically, the improvement lies in providing normal metal strips along the edges of the superconducting and normal metal layers parallel to the current flow in the TES during operation. These strips (referred to as "banks") provide for both improved detector performance and improved detector robustness against corrosion. This improvement is an important advance particularly for TES-based microcalorimeter detectors. The improved TESs also have many other applications based on the very precise thermometer function achieved by the TES.

37 Claims, 4 Drawing Sheets

